Docket No. 250061US2S DIV

## IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

IN RE APPLICATION OF: Shinsuke SAKAMOTO, et al.		GAU:	
SERIAL NO: New Divisional Application		EXAMINER:	
FILED:	Herewith		
	SEMICONDUCTOR INTEGRATED CIRCUIT DEVICE DESIGN METHOD	CE AND STANDARD CELL PLACEMENT	
REQUEST FOR PRIORITY			
COMMISSIONER FOR PATENTS ALEXANDRIA, VIRGINIA 22313			
SIR:			
Full benefit of the filing date of U.S. Application Serial Number 10/282,144, filed October 29, 2002, is claimed pursuant to the provisions of 35 U.S.C. §120.			
☐ Full bene <b>§119(e)</b> :	☐ Full benefit of the filing date(s) of U.S. Provisional Application(s) is claimed pursuant to the provisions of 35 U.S.C. §119(e): Application No. Date Filed		
Applicants claim any right to priority from any earlier filed applications to which they may be entitled pursuant to the provisions of 35 U.S.C. §119, as noted below.			
In the matter of the above-identified application for patent, notice is hereby given that the applicants claim as priority:			
COUNTRY Japan	<u>APPLICATION NUMBER</u> 2001-331294	MONTH/DAY/YEAR October 29, 2001	
Certified copies of the corresponding Convention Application(s)  ☐ are submitted herewith  ☐ will be submitted prior to payment of the Final Fee  ■ were filed in prior application Serial No. 10/282,144 filed October 29, 2002  ☐ were submitted to the International Bureau in PCT Application Number  Receipt of the certified copies by the International Bureau in a timely manner under PCT Rule 17.1(a) has been acknowledged as evidenced by the attached PCT/IB/304.  ☐ (A) Application Serial No.(s) were filed in prior application Serial No. filed ; and			
☐ (B) Application Serial No.(s)			
☐ are submitted herewith			
☐ will be submitted prior to payment of the Final Fee			
		Respectfully Submitted,	
		OBLON, SPIVAK, McCLELLAND, MAIER & NEUSTADT, P.C.  Eckhard H. Kuesters	
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2285	0		
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